



OVERVIEW

The SM5021 series are crystal oscillator module ICs fabricated in NPC's Molybdenum-gate CMOS, that incorporate high-frequency, low current consumption oscillator and output buffer circuits. Highly accurate thin-film feedback resistors and high-frequency capacitors are built-in, eliminating the need for external components to make a stable 3rd overtone oscillator.

FEATURES

- 3rd overtone oscillation
- Oscillator capacitors C_G, C_D built-in
- Inverter amplifier feedback resistor built-in (A×, B× series)
- TTL input level
- Output drive capability
 - $4\text{mA} (V_{DD} = 2.7\text{V})$
 - $8mA (V_{DD} = 4.5V)$

- Output three-state function
- Operating supply voltage range
 - 2.7 to 5.5V (A×, K× series)
 - 4.5 to 5.5V (B×, L× series)
- Oscillator frequency output
- 6-pin SOT (SM5021××H)
- Chip form (CF5021××)

SERIES CONFIGURATION

Version*1		g supply ange [V]	operating	mended frequency ² [MHz]	capac	it-in citance oF]	gm ratio	Rf [kΩ]	Output frequency	Output level	Standby output state
	Chip	SOT	3V operation	5V operation	C_{G}	C _D	Tallo	[KS2]	nequency	ievei	State
SM5021AAH	4.5 to 5.5	4.5 to 5.5	×	22 to 30			1	6.0			
SM5021ABH			22 to 30	30 to 43		15	1	3.3			
SM5021ACH	2.7 to 5.5	2.7 to 5.5	30 to 40	43 to 55	8	13	2	3.9	fo	CMOS	High impedance
SM5021ADH			40 to 50	55 to 70			3	2.7			
SM5021AEH	2.7 to 3.6	×	50 to 70	×		12	4	2.7			
SM5021BAH				22 to 30			1	6.0			
SM5021BBH	4.5 to 5.5	4.5 to 5.5	×	30 to 43	8	15	1	3.3	fo	TTL	Lligh impedance
SM5021BCH	4.5 10 5.5	4.5 10 5.5	×	43 to 55	0	13	2	3.9	1 10	IIL	High impedance
SM5021BDH				55 to 70			3	2.7			
SM5021KDH	2.7 to 5.5	2.7 to 5.5	22 to 50*3	22 to 70 ^{*3}	8	15	3		fo	CMOS	Lligh impedance
SM5021KEH	2.7 to 3.6	2.7 to 3.6	50 to 70 ^{*3}	×	0	12	4	4	10	CIVIOS	High impedance
SM5021LDH	4.5 to 5.5	4.5 to 5.5	×	22 to 70 ^{*3}	8	15	3	-	fo	TTL	High impedance

^{*1.} Chip form devices have designation CF5021 $\times\!\!\times$.

ORDERING INFORMATION

Device	Package
SM5021××H	SOT23-6
CF5021××-2	Chip form

^{*2.} The recommended operating frequency is a yardstick value derived from the crystal used for NPC characteristics authentication. However, the oscillator frequency band is not guaranteed. Specifically, the characteristics can vary greatly due to crystal characteristics and mounting conditions, so the oscillation characteristics of components must be carefully evaluated.

^{*3.} The 3rd overtone frequency range using an external resistor to set the cutoff frequency.

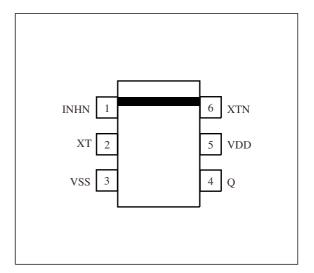
PAD LAYOUT

(Unit: µm)

$\begin{array}{c|cccc} Q & XTN & (1000,800) \\ \hline & & & & \\ & & HA5021 & \\ \hline & & & \\ & & & \\ \end{array} \\ VDD \\ \hline \\ (0,0) & VSS & XT & INHN \\ \hline \\ Chip size & : 1.00 \times 0.80mm \\ Chip thickness : 220 \pm 30 \mu m \\ Chip base & : V_{DD} | evel \\ \hline \end{array}$

PINOUT

(Top view)



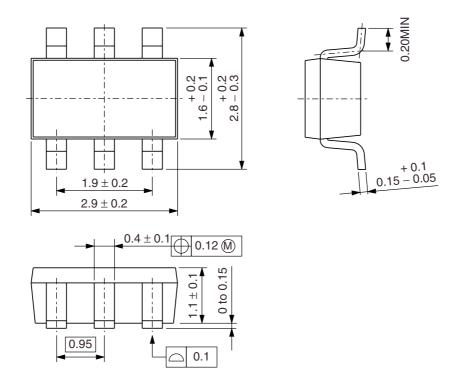
PIN DESCRIPTION and PAD DIMENSIONS

Number	Name	1/0	Description		Pad dimensions [µm	
Number	Name	1/0		Description		Υ
1	INHN	I	Output state control in	nput. High impedance when LOW. Pull-up resistor built in	771	150
2	XT	I	Amplifier input. Crystal oscillator connection pins. Crystal oscillator is connected between XT and XTN		553	150
3	VSS	-	Ground		150	140
4	Q	0	Output. Output freque	ency (f _O)	150	649
5	VDD	-	Supply voltage		796	409
6	XTN	0	Amplifier output.	Crystal oscillator connection pins. Crystal oscillator is connected between XT and XTN	836	636

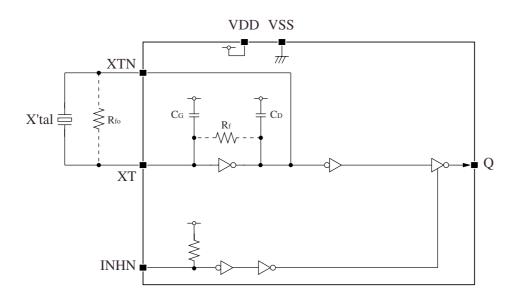
PACKAGE DIMENSIONS

(Unit: mm)

• 6-pin SOT



BLOCK DIAGRAM



SPECIFICATIONS

Absolute Maximum Ratings

$$V_{SS} = 0V$$

Parameter	Symbol	Condition	Rating	Unit
Supply voltage range	V _{DD}		- 0.5 to + 7.0	V
Input voltage range	V _{IN}		- 0.5 to V _{DD} + 0.5	V
Output voltage range	V _{OUT}		- 0.5 to V _{DD} + 0.5	V
Operating temperature range	T _{opr}		- 40 to + 85	°C
Ctorogo tomporatura rango		Chip form	- 65 to + 150	°C
Storage temperature range	T _{stg}	SOT23-6	- 55 to + 125	
Output current	I _{OUT}		13	mA
Power dissipation	P _D	SOT23-6	250	mW

Recommended Operating Conditions

$$V_{SS} = 0V$$
, $f \le 70MHz$, $C_L \le 15pF$

Parameter	Symbol	Condition		Unit		
Farameter	Syllibol	Condition	min	typ	max	Oille
Supply voltage	V _{DD}		2.7	-	5.5	V
Input voltage	V _{IN}		V _{SS}	-	V _{DD}	V
Operating temperature	T _{OPR}		– 20	-	+ 80	°C

Note: Recommended operating conditions will change in accordance with operating frequency, load capacitance, or power dissipation.

Electrical Characteristics

3V operation: AA, AB, AC, AD, AE, KD, KE series

 V_{DD} = 2.7 to 3.6V, V_{SS} = 0V, Ta = -20 to +80°C unless otherwise noted.

Davamatav	Symbol	Condition	_		Rating		Unit
Parameter	Symbol	Condition	II	min	typ	max	Unit
HIGH-level output voltage	V _{OH}	Q: Measurement cct 1, V _{DD} = 2.7V, I _{OH} = 4mA	SM5021×AH, CF5021×A SM5021×BH, CF5021×B SM5021×CH, CF5021×C SM5021×DH, CF5021×D	2.1	2.4	_	٧
		Q: Measurement cct 1, $V_{DD} = 2.7V$, $I_{OH} = 8mA$	SM5021×EH, CF5021×E				
LOW-level output voltage	V _{OL}	Q: Measurement cct 2, V _{DD} = 2.7V, I _{DL} = 4mA	SM5021×AH, CF5021×A SM5021×BH, CF5021×B SM5021×CH, CF5021×C SM5021×DH, CF5021×D	-	0.3	0.4	V
		Q: Measurement cct 2, V _{DD} = 2.7V, I _{OL} = 8mA	SM5021×EH, CF5021×E				
HIGH-level input voltage	V _{IH}	INHN		2.0	-	-	V
LOW-level input voltage	V _{IL}	INHN			_	0.5	V
Output leakage current	_	Q: Measurement cct 2, V _{DD} = 3.3V, IN	NHN = LOW, V _{OH} = V _{DD}	-	-	10	
Output leakage current	l _Z	Q: Measurement cct 2, V_{DD} = 3.3V, INHN = LOW, V_{OL} = V_{SS}			-	10	μA
Current consumption	I _{DD}	70MHz crystal oscillator, measurement cct 3, load cct 1, INHN = open, C _L = 15pF	SM5021A×H, CF5021A× SM5021K×H, CF5021K×	-	13	25	mA
INHN pull-up resistance	R _{UP}	Measurement cct 4	•	25	100	250	kΩ
			SM5021×AH, CF5021×A	5.1	6.0	6.9	
Feedback resistance			SM5021×BH, CF5021×B	2.8	3.3	3.8	
(A× series only)	R _f	Measurement cct 5	SM5021×CH, CF5021×C	3.3	3.9	4.5 kΩ	
			SM5021×DH, CF5021×D SM5021×EH, CF5021×E	2.3	2.7 3.1		
	C _G	Design value. A monitor pattern on a	wafer is tested.	7.44	8	8.56	pF
Built-in capacitance	C _D	Design value. A monitor pattern on a wafer is tested.	SM5021×AH, CF5021×A SM5021×BH, CF5021×B SM5021×CH, CF5021×C SM5021×DH, CF5021×D	13.95	15	16.05	pF
			SM5021×EH, CF5021×E	11.16	12	12.84	

5V operation: AA, AB, AC, AD, BA, BB, BC, BD, KD, LD series

 V_{DD} = 4.5 to 5.5V, V_{SS} = 0V, Ta = -20 to + 80° C unless otherwise noted.

Parameter	Symbol	Condition	_		Rating		Unit	
raidilletei	Syllibol	Condition	II.	min	typ	max	Ullit	
HIGH-level output voltage	V _{OH}	Q: Measurement cct 1, V _{DD} = 4.5V, I _C	_{DH} = 8mA	3.9	4.2	_	٧	
LOW-level output voltage	V _{OL}	Q: Measurement cct 2, V _{DD} = 4.5V, I _C	_{DL} = 8mA	-	0.3	0.4	٧	
HIGH-level input voltage	V _{IH}	INHN		2.0	-	-	٧	
LOW-level input voltage	V _{IL}	INHN		-	-	0.8	٧	
Output lookogo gurrant		Q: Measurement cct 2, V _{DD} = 5.5V, IN	NHN = LOW, V _{OH} = V _{DD}	-	-	10		
Output leakage current	l _Z	Q: Measurement cct 2, V _{DD} = 5.5V, IN	NHN = LOW, V _{OL} = V _{SS}	-	-	10	μA	
Current consumption I _{DD}		70MHz crystal oscillator, measurement cct 3, load cct 1, INHN = open, C _L = 15pF	SM5021AAH, CF5021AA SM5021ABH, CF5021AB SM5021ACH, CF5021AC SM5021ADH, CF5021AD SM5021KDH, CF5021KD	-	18	35	mA	
		70MHz crystal oscillator, measurement cct 3, load cct 2, INHN = open, C _L = 15pF	SM5021B×H, CF5021B× SM5021L×H, CF5021L×	-	18	35		
INHN pull-up resistance	R _{UP}	Measurement cct 4		25	100	250	kΩ	
			SM5021×AH, CF5021×A	5.1	6.0	6.9		
Feedback resistance	R _f	Measurement cct 5	SM5021×BH, CF5021×B	2.8	3.3	3.8	kΩ	
(A \times , B \times series only)	n _f	Measurement cct 5	SM5021×CH, CF5021×C	3.3	3.9	4.5		
			SM5021×DH, CF5021×D	2.3	2.7	3.1		
	C _G		SM5021×AH, CF5021×A	7.44	8	8.56	pF	
Built-in capacitance	C _D	Design value. A monitor pattern on a wafer is tested.	SM5021×BH, CF5021×B SM5021×CH, CF5021×C SM5021×DH, CF5021×D	13.95	15	16.05	pF	

Switching Characteristics

CMOS Output Version

3V operation: AA, AB, AC, AD, AE, KD, KE series

 $V_{\rm DD}$ = 2.7 to 3.6V, $V_{\rm SS}$ = 0V, Ta = - 20 to + 80°C unless otherwise noted.

Parameter	Cumbal	Condition	Condition		Rating		Unit
Parameter	Symbol	Condition		min	typ	max	Unit
		Measurement cct 6, load cct 1, 0.1V _{DD} to 0.9V _{DD} , C _L = 15pF	SM5021AAH, CF5021AA SM5021ABH, CF5021AB SM5021ACH, CF5021AC SM5021ADH, CF5021AD SM5021KDH, CF5021KD	-	5	10	
Output rise time	t _{r1}		SM5021AEH, CF5021AE SM5021KEH, CF5021KE	-	3.5	7	ns
		Measurement cct 6, load cct 1, 0.2V _{DD} to 0.8V _{DD} , C _L = 15pF SM5021ADH, CF5021AD SM5021ADH, CF5021AD SM5021KDH, CF5021KD		-	3.5	7	
		Measurement cct 6, load cct 1, 0.9V _{DD} to 0.1V _{DD} , C _L = 15pF	SM5021AAH, CF5021AA SM5021ABH, CF5021AB SM5021ACH, CF5021AC SM5021ADH, CF5021AD SM5021KDH, CF5021KD	-	5	10	
Output fall time	t _{f1}		SM5021AEH, CF5021AE SM5021KEH, CF5021KE	-	3.5	7	ns
		Measurement cct 6, load cct 1, 0.8V _{DD} to 0.2V _{DD} , C _L = 15pF	SM5021AAH, CF5021AA SM5021ABH, CF5021AB SM5021ACH, CF5021AC SM5021ADH, CF5021AD SM5021KDH, CF5021KD	-	3.5	7	
Output duty cycle*1	Duty	Measurement cct 6, load cct 1, V_{DD} = 3V, Ta = 25°C, C_L = 15pF, $f \le 70 MHz$		45	-	55	%
Output disable delay time	t _{PLZ}	Measurement cct 6, load cct 1, V _{DD} = 3	RV Ta = 25°C C. = 15pE	_	-	100	ns
Output enable delay time	t _{PZL}	Wiedsurement cot o, load cot 1, VDD = 3	σν, ια – 20 O, OL = 10μΓ	_	-	100	ns

^{*1.} The duty cycle characteristic is checked the sample chips of each production lot.

5V operation: AA, AB, AC, AD, KD series

 V_{DD} = 4.5 to 5.5V, V_{SS} = 0V, Ta = -20 to + 80° C unless otherwise noted.

Parameter	Cumbal	mbol Condition		Rating		
raiailletei	Syllibol			typ	max	Unit
Output rise time	t _{r1}	Measurement cct 6, load cct 1, 0.1V _{DD} to 0.9V _{DD} , C _L = 15pF	-	3.5	7	ns
Output fall time	t _{f1}	Measurement cct 6, load cct 1, 0.9V _{DD} to 0.1V _{DD} , C _L = 15pF	-	3.5	7	ns
Output duty cycle*1	Duty	Measurement cct 6, load cct 1, V_{DD} = 5V, Ta = 25°C, C_L = 15pF, f \leq 70MHz	45	-	55	%
Output disable delay time	t _{PLZ}	Measurement cct 6, load cct 1, V _{DD} = 5V, Ta = 25°C, C ₁ = 15pF	-	-	100	ns
Output enable delay time	t _{PZL}	Measurement cct o, load cct 1, vDD = 3v, 1a = 25 C, CL = 15pF	-	-	100	ns

^{*1.} The duty cycle characteristic is checked the sample chips of each production lot.

TTL Output Version

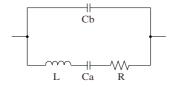
5V operation: BA, BB, BC, BD, LD series

 $V_{\rm DD}$ = 4.5 to 5.5V, $V_{\rm SS}$ = 0V, Ta = - 20 to + 80°C unless otherwise noted.

Parameter	Symbol	mbol Condition		Rating		
raiailletei	Syllibol			typ	max	Unit
Output rise time	t _{r2}	Measurement cct 6, load cct 2, 0.4V to 2.4V, C _L = 15pF	-	2.5	7	ns
Output fall time	t _{f2}	Measurement cct 6, load cct 2, 2.4V to 0.4V, C _L = 15pF	-	2.5	7	ns
Output duty cycle*1	Duty	Measurement cct 6, load cct 2, V_{DD} = 5V, Ta = 25°C, C_L = 15pF, f \leq 70MHz	45	-	55	%
Output disable delay time	t _{PLZ}	Measurement cct 6, load cct 2, V _{DD} = 5V, Ta = 25°C, C ₁ = 15pF	-	-	100	ns
Output enable delay time	t _{PZL}	Mieasurement cct o, load cct 2, VDD = 5V, 1d = 25 C, CL = 15pr	ı	-	100	ns

^{*1.} The duty cycle characteristic is checked the sample chips of each production lot.

Current consumption and Output waveform with NPC's standard crystal



f [MHz]	R [Ω]	L [mH]	Ca [fF]	Cb [pF]
30	18.62	16.24	1.733	5.337
40	20.53	11.34	1.396	3.989
50	22.17	7.40	1.370	4.105
60	22.20	5.05	1.388	4.226
70	25.42	4.18	1.254	5.170

FUNCTIONAL DESCRIPTION

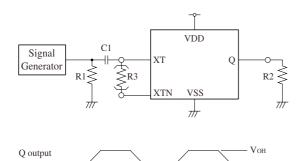
Standby Function

When INHN goes LOW, the oscillator output on Q goes high impedance.

INHN	Q	Oscillator
HIGH (or open)	f _O	Normal operation
LOW	High impedance	Normal operation

MEASUREMENT CIRCUITS

Measurement cct 1



2.0Vp-p, 10MHz sine wave input signal (3V operation) 3.5Vp-p, 10MHz sine wave input signal (5V operation)

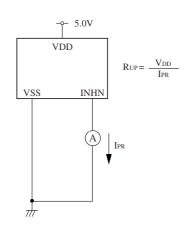
 $\begin{array}{l} \text{C1:}\ 0.001 \mu\text{F} \\ \text{R1:}\ 50\Omega \end{array}$

R2: 525Ω (3V operation/ \times A, \times B, \times C, \times D series)

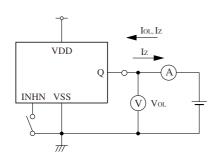
263 Ω (3V operation/ \times E series)

490 Ω (5V operation) R3: 100k Ω (K×, L× series)

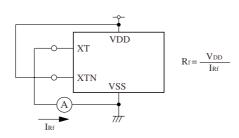
Measurement cct 4



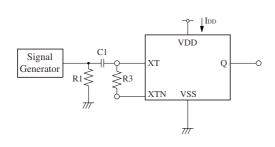
Measurement cct 2



Measurement cct 5



Measurement cct 3

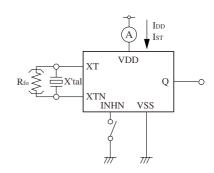


2.0Vp-p, 70MHz sine wave input signal (3V operation) 3.5Vp-p, 70MHz sine wave input signal (5V operation)

C1: 0.001μF R1: 50Ω

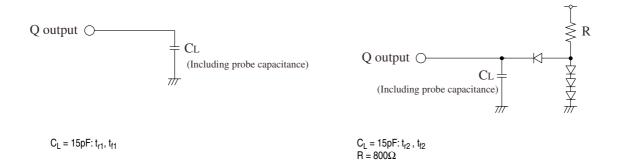
R3: $100k\Omega$ (K×, L× series)

Measurement cct 6



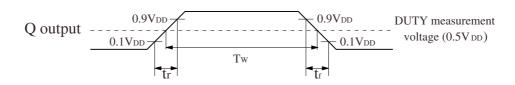
 R_{fo} : 2.7k Ω (K×, L× series)

Load cct 1 Load cct 2

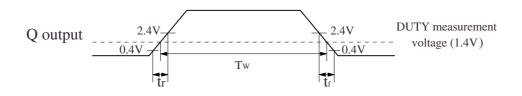


Switching Time Measurement Waveform

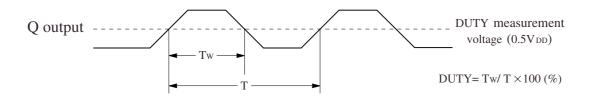
Output duty level (CMOS)



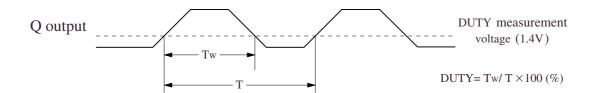
Output duty level (TTL)



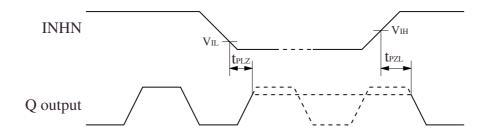
Output duty cycle (CMOS)



Output duty cycle (TTL)



Output Enable/Disable Delay



INHN input waveform $tr = tf \le 10$ ns

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